

	Subclass	ISSUE CLASSIFICATION
	Class	



PATENT NUMBER

U.S. UTILITY Patent Application

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APPLICATION NO. 09/819520	CONT/PRIOR	CLASS 385 389	SUBCLASS 25	ART UNIT 2874 2633	EXAMINER Sanghavi
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APPLICANTS
TITLE

Ansheng Liu
Marie Risticic

Method and apparatus for interleaving and switching an optical beam in a semiconductor substrate

ISSUING CLASSIFICATION

DRAWINGS

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